

## 40V, 10mΩ, 10A, Single N-Channel

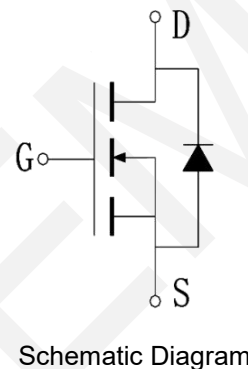
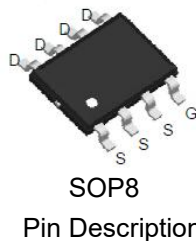
### 1.Features

- ◆ 40V MOSFET technology
- ◆ Low on-state resistance
- ◆ Fast switching
- ◆  $V_{GS} \pm 20V$

$V_{DS}$	$R_{DS(on)}$ Typ.	$I_D$ Max.
40V	10mΩ @ 10V	10A
	13mΩ @ 6V	
	20mΩ @ 4.5V	

### 2.Applications

- ◆ Power Switching Application
- ◆ Load Switching



### 3.Absolute Max Ratings at $T_a=25^\circ C$ (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{DSS}$	40	V
Gate to Source Voltage	$V_{GSS}$	$\pm 20$	V
Drain Current (DC)	$I_D$	10	A
Drain Current (Pulse), $PW \leq 300\mu s$	$I_{DP}$	120	A
Total Dissipation	$P_D$	1.7	W
Avalanche Energy, Single Pulsed	$E_{AS}$	64	mJ
Junction Temperature	$T_j$	150	$^\circ C$
Storage Temperature	$T_{stg}$	-55 to +150	$^\circ C$

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### 4.Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction-to-Ambient	$R_{\theta JA}$	31	$^\circ C/W$

Note 2: When mounted on 1 inch square copper board  $t \leq 10$ sec The value in any given application depends on the user's specific board design.

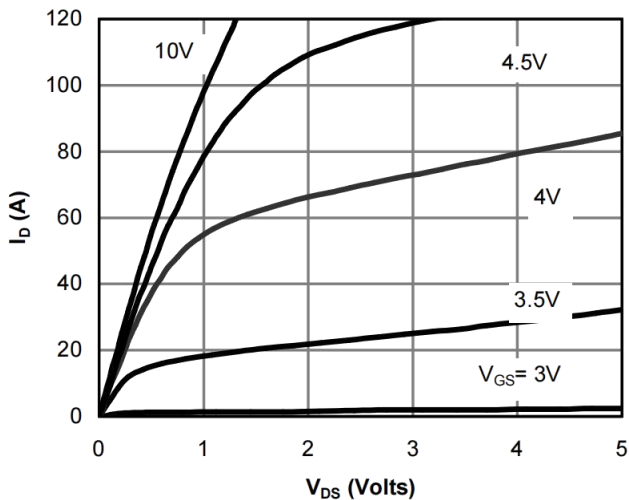
**5. Electrical Characteristics at Ta=25°C (Note 3)**

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = 250\mu A, V_{GS} = 0V$	40	45		V
Zero-Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 40V, V_{GS} = 0V$			1	$\mu A$
Gate to Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			$\pm 100$	nA
On state drain current	$I_{D(ON)}$	$V_{GS} = 10V, V_{DS} = 5V$	120			A
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_{DS}=250\mu A$	1	1.6	2.5	V
Static Drain to Source On-State Resistance	$R_{DS(on)}$	$I_D = 10A, V_{GS} = 10V$	-	10	13	m $\Omega$
		$I_D = 8A, V_{GS} = 6V$	-	13	19	m $\Omega$
		$I_D = 8A, V_{GS} = 4.5V$	-	20		m $\Omega$
Input Capacitance	$C_{iss}$	$V_{GS}=0V,$		1500		pF
Output Capacitance	$C_{oss}$	$V_{DS}=20V,$		215		pF
Reverse Transfer Capacitance	$C_{rss}$	Frequency=1.0MHz		135		pF
Turn-ON Delay Time	$t_{d(on)}$	$V_{DD} = 20V, R_L = 2\Omega$ $V_{GS} = 10V, R_G = 3\Omega$		6.4		ns
Rise Time	$t_r$			17		ns
Turn-OFF Delay Time	$t_{d(off)}$			30		ns
Fall Time	$t_f$			16.8		ns
Total Gate Charge	$Q_g$		$V_{DS} = 20V,$		27.2	
	$Q_{gs}$	$V_{GS} = 10V,$		4.5		nC
	$Q_{gd}$	$I_D = 10A$		6.4		nC
Diode Forward Voltage	$V_{FSD}$	$I_S = 10A, V_{GS} = 0$		0.8	1.2	V

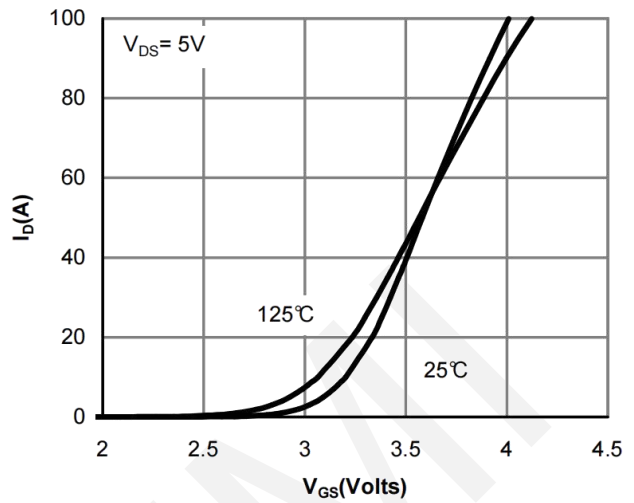
Note 3 : Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



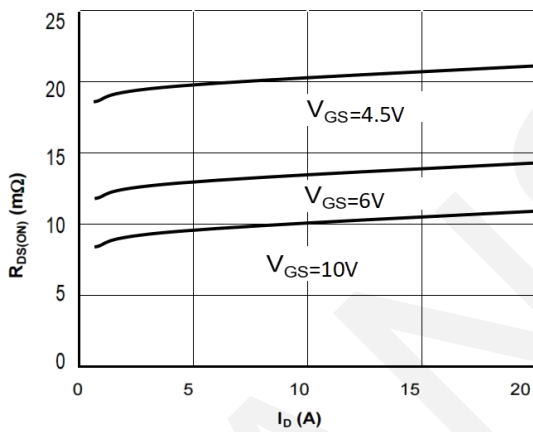
### 6. Typical electrical and thermal characteristics



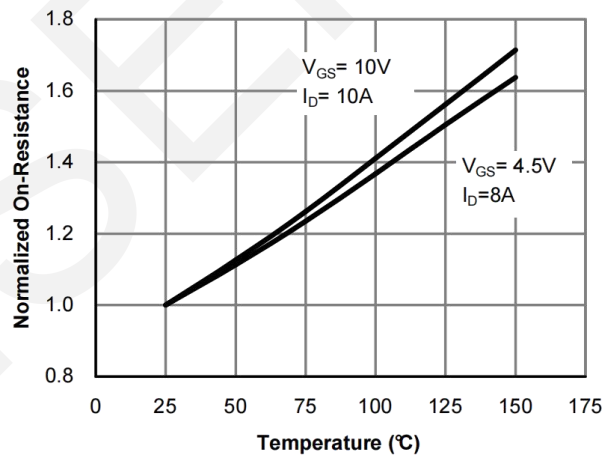
On-Region Characteristics



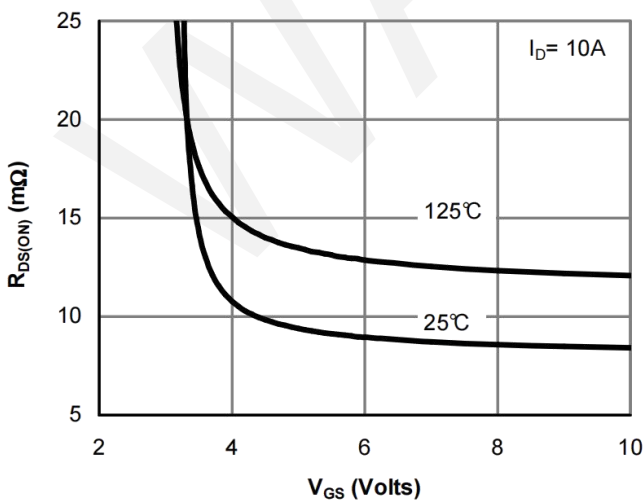
Transfer Characteristics



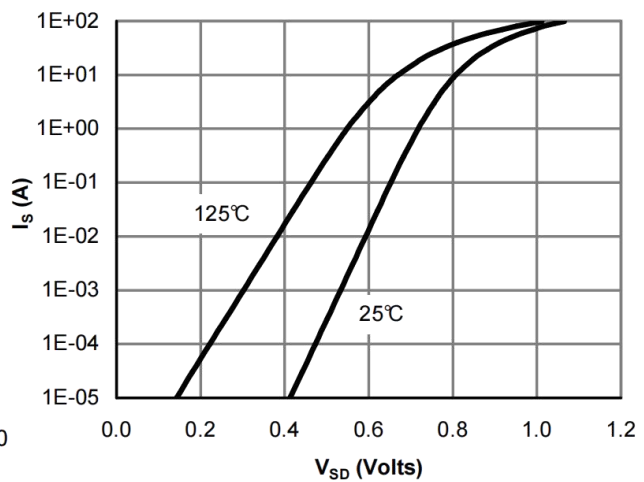
Rdson-Drain Current



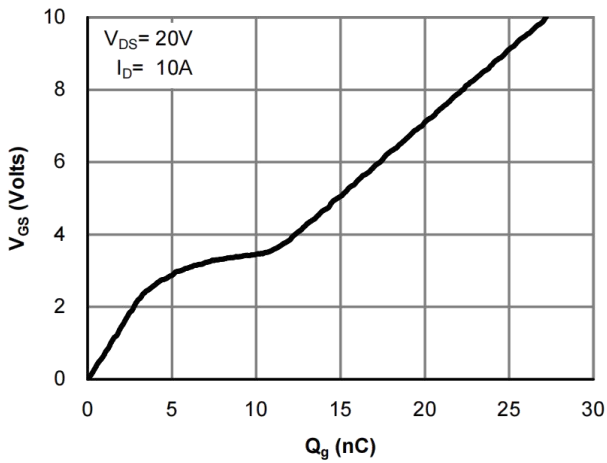
Rdson-Junction



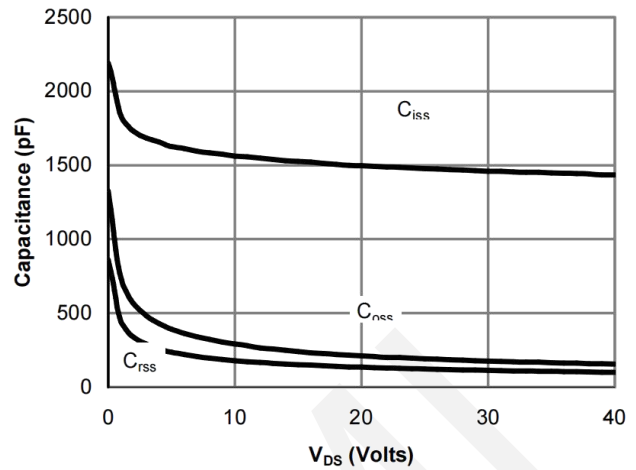
On-Resistance vs. Gate-Source Voltage



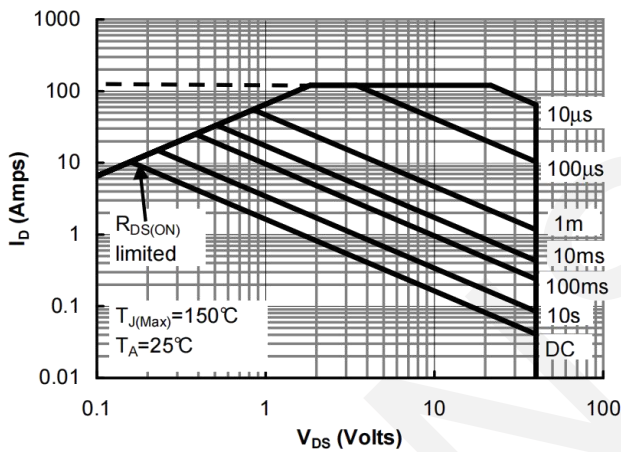
Body-Diode Characteristics



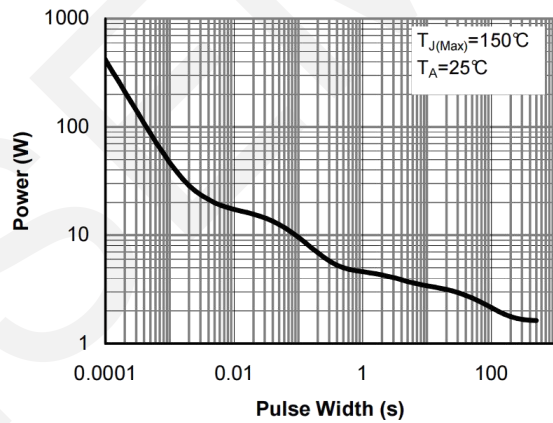
**Gate-Charge Characteristics**



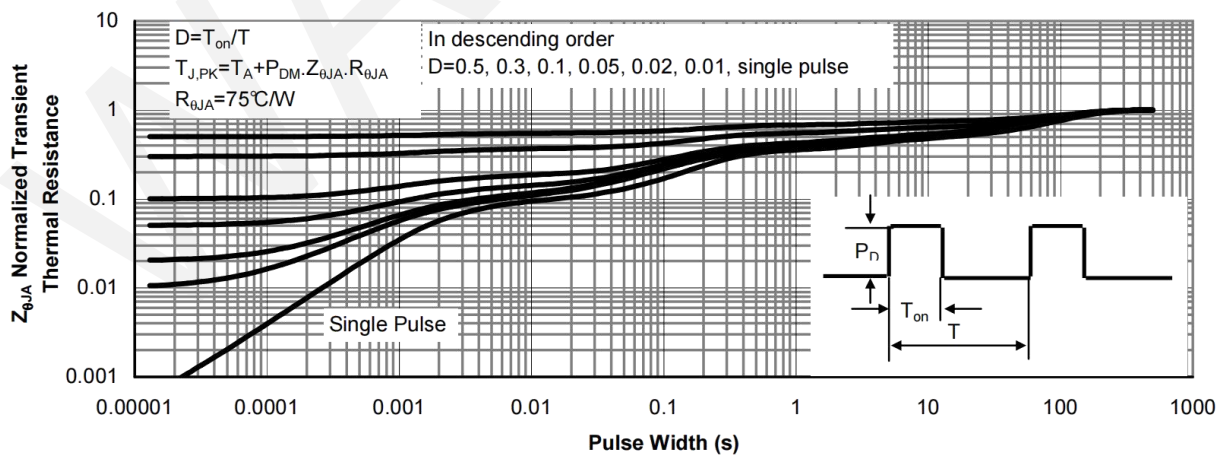
**Capacitance Characteristics**



**Maximum Forward Biased Safe Operating Area**



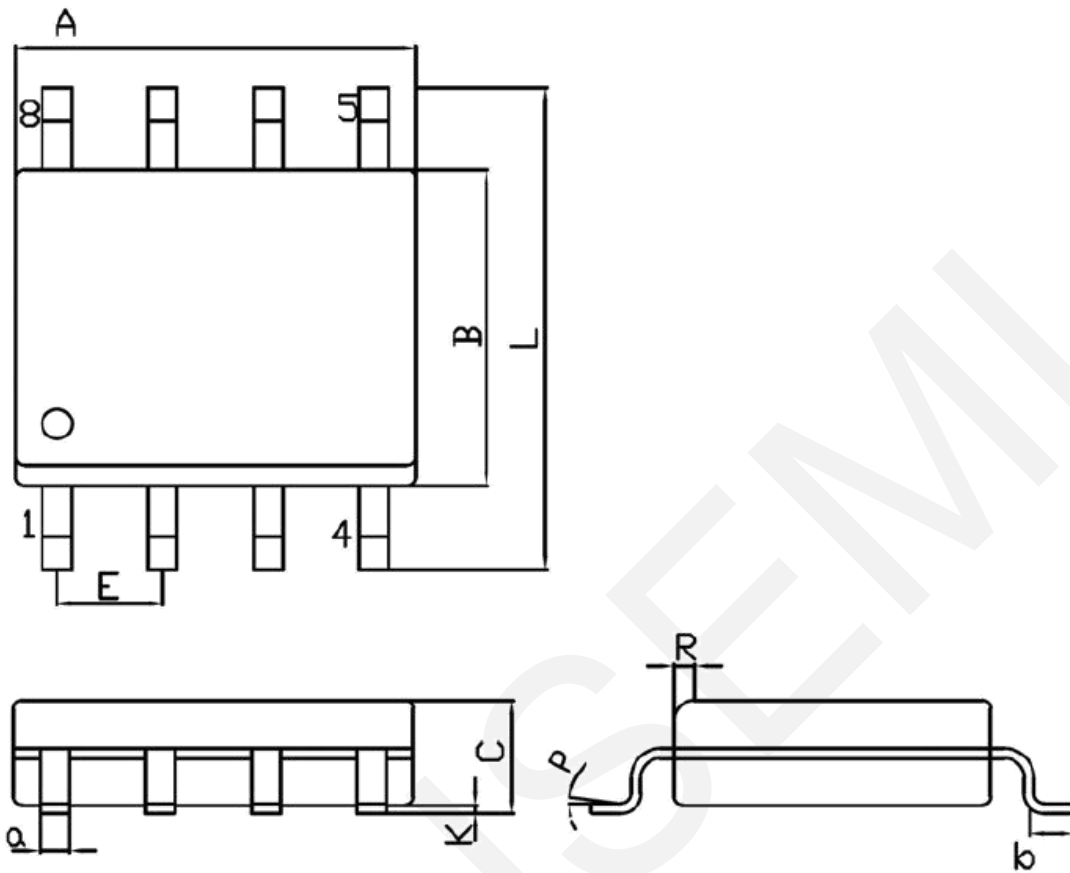
**Single Pulse Power Rating Junction-to-Ambient**



**Normalized Maximum Transient Thermal Impedance**



**7.Package Dimensions**



Symbol	Dimensions In Millimeters		Symbol	Dimensions In Millimeters	
	Min	Max		Min	Max
A	4.70	5.10	c	1.35	1.75
B	3.70	4.10	a	0.35	0.49
L	5.80	6.20	R	0.30	0.60
E	1.27BSC		P	0°	7°
K	0.12	0.22	b	0.40	1.25

## 8. Important Notice

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